



IntelliFET HIGH-SIDE POWER SWITCH

Description

The ZXMS82180S14PQ is a dual-channel high-side power switch in a SO-14EP exposed heatsink package incorporating protective and diagnostic functions.

The device comprises a monolithic n-channel vertical power MOSFET with integrated temperature and current sensors with a charge-pumped gate supply and has a low quiescent current in OFF state.

The device is enabled by active high 3.3V and 5V logic-level drive to the inputs. The device includes a diagnostic current-sense output proportional to load current and a defined diagnostic fault signal in case of overload operation, overtemperature, short-circuit or open-load conditions.

Features

Protection Functions

- Reverse Battery Protection Using External Components
- Voltage Dependent Current Limiting
- Overtemperature Protection with Auto-Restart
- Overvoltage Protection Including Load Dump
- Stable Undervoltage Protection
- ESD Protection
- Loss of Ground Protection with External Components
- Enhanced Short-Circuit Protection

Diagnostic Functions

- Proportional Load Current-Sense Output
 - Linear Voltage Drop Regulation to Maintain Sense Accuracy Even at Very Low Load Currents
 - Enabled by Logic Input
 - Output Channel Selected by Logic Input
 - Defined Temperature and Current Dependency
- Open-Load Detection
 - Using Load Current-Sense in ON State
 - Using Output Voltage Detection in OFF State
- Defined Fault Signal in Case of Overload Operation,
 Overtemperature, or Short-Circuit and Open-Load in OFF State

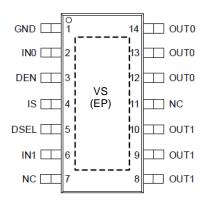
Miscellaneous

- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- The ZXMS82180S14PQ is suitable for automotive applications requiring specific change control; this part is AEC-Q100 qualified, PPAP capable, and manufactured in IATF16949 certified facilities.

https://www.diodes.com/quality/product-definitions/

Pin Assignment

(Top View)



SO-14EP

Applications

- High-side switching with diagnostic feedback for:
 - 12V grounded loads
 - Resistive, inductive and capacitive loads
- Suitable for high inrush current loads
 - Incandescent lamps (P5W), motors, LEDs, etc.
- Compact low power replacement for:
 - Relays, fuses and discrete circuits

Summary Specifications

Parameter	Symbol	Rating
Operating Voltage	Vs	5V to 28V
Maximum Supply Voltage	V _{S(LD)}	41V
Maximum ON Resistance, T _J = +150°C	RDS(ON)	360mΩ
Nominal Load Current	I _{L(NOM)}	2A
Typical Current Sense Ratio	K _{ILIS}	550
Minimum Current Limitation	I _{L5} (SC)	8A
Maximum Standby Current, T _J = +25°C	Is(OFF)	0.5μΑ

Notes:

- 1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.



Typical Applications Circuit

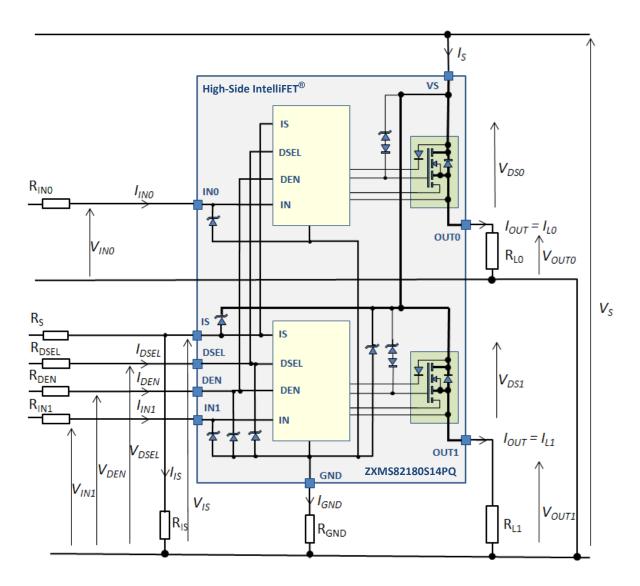


Figure 1. Typical Application Configuration

RGND, RINX, RDEN, RDSEL and Rs are optional. They may be replaced by shorts depending on the application. Non-zero resistors may be used to:

- Reduce peak currents during supply voltage transients that exceed the ±Vs internal clamp voltages
 - Typically transients exceeding 41V or may activate the internal clamps
- Protect the customer's application from high currents during transients exceeding 41V
- Keep within rated current during reverse battery, recommended is Rs = RDEN = RINX = RDEL = 4.7kΩ, RGND = 150Ω
- Ensure that the device is off when there is loss of ground connection to the device or module



Pin Description

Pin Number	Pin Name	Function and Description
1	GND	Ground or negative supply
2	IN0	Input channel 0, activates output channel 0
3	DEN	Diagnostic enable, allows common connection of the IS pin with multiple devices
4	IS	Diagnostic output, provides an analog sense current proportional to the load current under normal operation, or a defined current under overload or shutdown conditions
5	DSEL	Input to select which channel to be diagnosed
6	IN1	Input channel 1, activates output channel 1
7, 11	NC	Not connected
8, 9, 10	OUT1	Output 1 to the load, must be connected together
12, 13, 14	OUT0	Output 0 to the load, must be connected together
EP	VS	Voltage supply or battery positive

Table 1. Pin Description

Functional Block Diagram

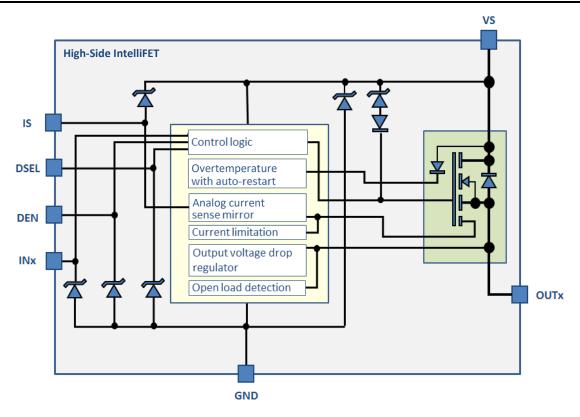


Figure 2. Functional Block Diagram of ZXMS82180S14PQ



Absolute Maximum Ratings (Notes 4, 5) (@T_J = +25°C, unless otherwise specified.)

	_	Rat	ings		
Symbol	Parameter	Min	Max	Unit	Conditions
Supply Voltage	e				
Vs	Supply voltage	-0.3	28	V	_
V _{S(REV)}	Reverse supply voltage	0	16	V	$R_L \ge 6\Omega$, $R_{GND} = 150\Omega$ $T_{amb} = +25^{\circ}C$, $t < 2$ mins
Vs(sc)	Supply voltage for short-circuit protection (Note 6)	0	24	>	_
V _{S(LD)}	Supply voltage for load-dump protection (ISO 7637)	_	41	V	$R_{IN} = 2\Omega$, $R_L = 12\Omega$
Interface Pins					
Mari	INI ning voltage	-0.3	6	٧	_
Vin	IN pins voltage	_	7	V	t < 2 mins
I _{IN}	Current in IN pins	-2	2	mA	_
,,	DENI dia college	-0.3	6	V	_
Vden	DEN pin voltage	_	7	٧	t < 2 mins
IDEN	Current in DEN pin	-2	2	mA	_
.,	DOEL : II	-0.3	6	V	_
V _{DSEL}	DSEL pin voltage	_	7	V	t < 2 mins
IDSEL	Current in DSEL pin	-25	50	mA	_
Vis	IS pin voltage	-0.3	Vs	٧	_
lıs	Current in IS pin	-25	50	mA	_
Output Stage		•	1		
IL	Load current (Note 7)	_	Self-limited	Α	_
Ртот	Power dissipation	_	1.6	W	T _{amb} = +85°C, T _J < +150°C
Eas	Energy dissipation (single pulse, one channel)	_	30	mJ	Vs = 13.5V, IL = 1A T _J = +150°C
VDS	VS to OUT pin voltage	_	41	V	_
N _{RSC}	Repetitive short-circuit capability (Note 8)	_	300	kcyc	t _{ON} = 300ms
Current					
	Company in CNID win	-10	10	mA	_
I _{GND}	Current in GND pin	-150	20	mA	t < 2 mins
Temperature					
TJ	Junction temperature	-40	150	°C	_
Tstg	Storage temperature	-55	150	°C	_
Electrostatic I	Discharge	•			
.,	ESD capability HBM (all pins)	-2	2	kV	EIA/IEOD 00 A 4445
VESD(HBM)	ESD capability HBM OUT to GND and Vs shorted	-4	4	kV	EIA/JESD 22-A 114B
VESD(CDM)	ESD capability CDM	-0.75	0.75	kV	AEC-Q100-011

Notes:

^{4.} Stresses greater than those listed under *Absolute Maximum Ratings* can cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to *Absolute Maximum Ratings* for extended periods can affect device reliability.

^{5.} Not subject to production test, guaranteed by design.

^{6.} Short-circuit protection is outside normal operation and is limited to single pulse and allows combinations of resistance and inductance.

^{7.} Current limit is a protection feature and operation in current limitation, e.g. with short-circuit loads, is outside the normal operation range.

^{8.} Repetitive short-circuit protection characterisation also carried out according to AEC-Q100-012 at 14V.



Package Thermal Data

Symbol	Parameter	Min	Тур	Max	Unit
R ₀ JS	Thermal resistance, junction-to-soldering point (Note 5)	_	4	_	°C/W
R _θ ЈА	Thermal resistance, junction-to-ambient mounted on PCB Both channels active (Notes 5, 9)	-	46	_	°C/W

Note:

Recommended Operating Conditions

Symbol	Parameter	Min	Max	Unit
Vs(NOM)	Normal operating voltage (Note 10)	8	18	V
Vs(op)	Extended operating voltage (Note 11)	5	28	V

Notes:

Operational Electrical Characteristics

(Unless otherwise specified: -40° C < T_J < $+150^{\circ}$ C; typical values based on T_J = $+25^{\circ}$ C)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
General						
Vs(OP)	Extended operating voltage	V _{IN} = 4.5V, V _{DS} < 0.5V	5	13.5	28	V
Vs(op_min)	Undervoltage restart	$V_{IN} = 4.5V, R_L = 12\Omega$	3.8	4.2	5	٧
Vs(UV)	Undervoltage shutdown	$V_{IN} = 4.5V$, $V_{DEN} = 0V$ $R_L = 12\Omega$	3	3.3	4.1	V
Vs(uv_Hys)	Undervoltage hysteresis	_	_	0.85	_	V
Lava	Operating current One channel active	V _{IN} = V _{DEN} = 5.5V, V _S = 18V	_	2.5	6	mA
IGND	Operating current Both channels active	Device in R _{DS(ON)}	_	3.5	8	mA
1	Is(OFF) Standby current	V _{IN} and V _{DEN} floating V _{OUT} = 0V, V _S = 18V T _J ≤ +85°C	_	0.1	0.5	μА
IS(OFF)		V_{IN} and V_{DEN} floating $V_{OUT} = 0V$, $V_{S} = 18V$ $T_{J} = +150^{\circ}C$	_	2	20	μA
I _{S(OFF_DEN)}	Standby current with diagnostic pin active	V _{IN} floating, V _{OUT} = 0V V _S = 18V, V _{DEN} = 5.5V	_	1	_	mA

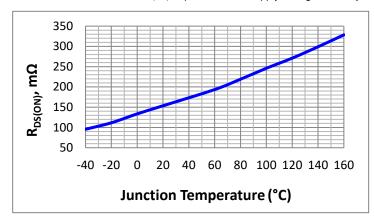
^{9.} Device mounted on vertical PCB, 2" x 2" x 1.6mm, FR4 with 2oz copper for all connections.

 ^{10.} For normal operation and protection features.
 11. Operation across an extended range is possible but is load dependant – device may have reduced protection against faulty (overload or short-circuit loads.



On-State Characteristics

The ON-state resistance R_{DS(ON)} depends on the supply voltage V_S and junction temperature T_J.



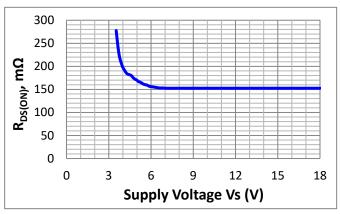


Figure 3. Typical RDS ON-State Resistance

At low load current I_L , the MOSFET gate drive is reduced to maintain a near constant output voltage drop $V_{DS(NL)}$. This limits the effect of internal op-amp offset voltage, to maintain useful K_{ILIS} ratio accuracy even at very low I_L .

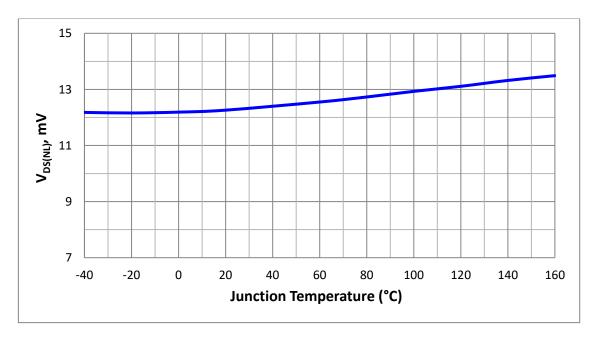


Figure 4. Output Voltage Drop Regulation, IOUT = 30mA



Resistive Load Switching

The power MOSFET turn-ON and turn-OFF processes are determined by the device itself, with rates suitable for EMC compatibility.

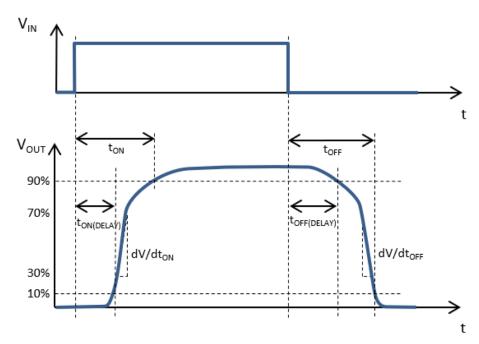


Figure 5. Switching a Resistive Load

Output Inductive Load Clamp

To de-energise inductive loads the OUT terminal must be allowed to swing below ground (Vout rings negative) during the OFF-state.

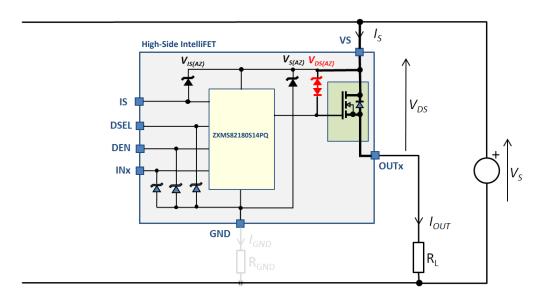


Figure 6. Output Clamp



Output Inductive Load Clamp (continued)

A low-impedance active voltage clamp uses the MOSFET channel to limit the maximum voltage across the MOSFET drain-source terminals, limiting the swing of OUT below V_S to safe $V_{DS(AZ)}$. This prevents avalanche of the MOSFET or associated circuitry.

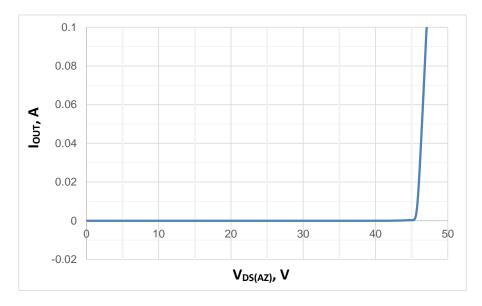


Figure 7. Typical Output Clamp Characteristic

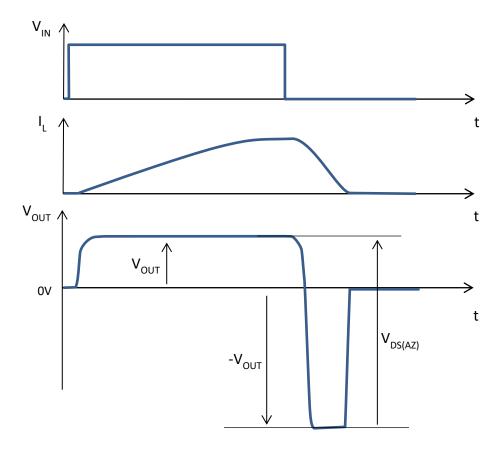


Figure 8. Switching an Inductive Load



Maximum Load Inductance

Stored inductive load ring-OFF energy is dissipated in the MOSFET during switching and load ring-OFF clamping. Additional energy is also supplied to the system by the Vs supply until the load current I_L reaches zero. This causes a temporary rise in MOSFET temperature after turn-OFF begins. The temperature reached depends on the starting temperature, thermal environment, load current I_L, load inductance L_L, load resistance R_L and supply voltage Vs.

Inverse Current Capability

In the ON-state the device will remain on if the output current becomes inverse until or unless the inverse current becomes high enough to create a -V_{DS} approaching body diode conduction. During inverse current conduction, I_{L(INV)}, the IS sense output will be zero. If body diode conduction occurs all functions are disabled or unspecified until the inverse current becomes very small.

If inverse current is present in the OFF-state body diode conduction occurs and all functions are disabled or unspecified. When inverse current is removed or becomes very small then turn-ON and normal function become possible.

Power Electrical Characteristics

(Unless otherwise specified: 8V < Vs < 18V, -40°C < T_J < +150°C; typical values based on Vs = 13.5V, T_J = +25°C)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
Output Characteristics								
D	ON atota registance per channel	V _{IN} = 4.5V, I _L = 2A T _J = +150°C	_	300	360	mΩ		
R _{DS(ON)}	ON-state resistance per channel	$V_{IN} = 4.5V, I_{L} = 2A$ $T_{J} = +25^{\circ}C$	_	150	_	mΩ		
I _{L(NOM)}	Nominal load current One channel active (Note 12)	T _{amb} = +85°C, T _J < +150°C	_	2	_	А		
IL(NOM)	Nominal load current Both channels active (Note 12)	Tamb = +03 C, 13 < +130 C	_	1.5	_	Α		
VDS(NL)	Voltage drop regulation at low I∟	I _L = 30mA	_	12	25	mV		
VDS(AZ)	Output clamp voltage	I _L = 20mA	41	47	53	V		
li come	Output leakage current per channel	VIN floating, $V_{OUT} = 0V$ T _J $\leq +85$ °C	_	0.1	0.5	μΑ		
I _L (OFF)	Output leakage current per channel	V_{IN} floating, $V_{OUT} = 0V$ $T_J = +150$ °C	_	1	10	μΑ		
I _L (INV)	Inverse output current (Note 13)	Vs < Vout	_	1.5	_	Α		
Timings								
dV/dton	Slew rate ON, 30% to 70% Vs		0.1	0.25	0.5	V/µs		
dV/dtoff	Slew rate OFF, 70% to 30% Vs		0.1	0.25	0.5	V/µs		
ton	Turn-ON time to 90% Vs	D 420 V 42 5V	30	90	230	μs		
toff	Turn-OFF time to 10% V _S	$R_L = 12\Omega, V_S = 13.5V$	30	170	300	μs		
ton(delay)	Turn-ON delay to 10% Vs		10	25	100	μs		
toff(DELAY)	Turn-OFF delay to 90% Vs		10	95	200	μs		
Eon	Switch ON energy	$R_L = 12\Omega, V_S = 18V$ $V_{OUT} = 90\% V_S$	_	0.4	_	mJ		
Eoff	Switch OFF energy	$R_L = 12\Omega$, $V_S = 18V$ $V_{OUT} = 10\% V_S$	_	0.4	_	mJ		

Notes:

- 12. Device mounted on vertical 50mm x 50mm x 1.5mm FR4 single-sided PCB with 6cm² 2oz copper in free air.
- 13. ON-state reverse conduction, functional test only.



Protection Features

Loss of Ground Protection

The device will turn off in the case that the ground pin connection is lost and the load remains connected. It is recommended to use high ohmic input resistors in the interface pins to ensure that the device is turned off by limiting the current in the paths from the ground pin, through the input and diagnostic enable ESD diodes, to the external driving circuits.

Undervoltage Protection

The device will not turn on if the Vs supply voltage is below the minimum operating voltage $V_{S(OP_MIN)}$ where protection functions may not be operational. If the device is already on then the supply voltage has to drop to below the undervoltage threshold $V_{S(UV)}$ to turn the output off. Figure 9 shows the undervoltage mechanism.

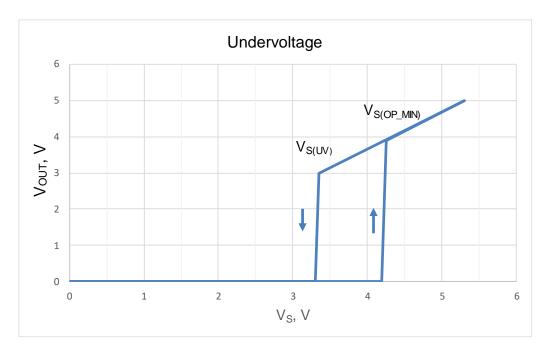


Figure 9. Undervoltage Behavior



Protection Features (continued)

Overvoltage Protection

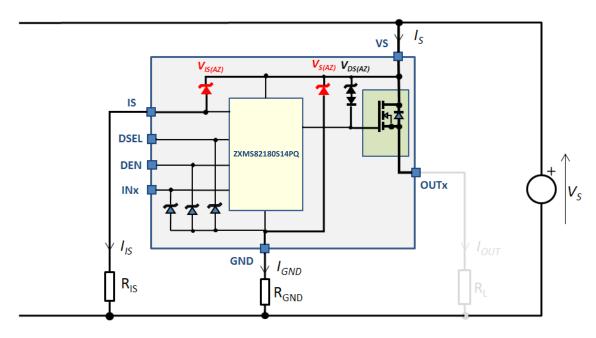


Figure 10. Overvoltage Clamping Circuit

The GND pin has an active protection clamp, operating much as a low noise high voltage Zener device, to protect it from overvoltage for high V_S transients. During V_S transient overvoltage the voltage is clamped and the excess voltage, V_S - $V_{S(AZ)}$, is applied across the ground resistor R_{GND} raising the potential on the ground pin. Additional high ohmic series resistors may be needed to prevent high V_{IN} and V_{DEN} being applied directly to the driving circuits.

The IS pin also has an active protection clamp and during V_S transient overvoltage the voltage is clamped and excess voltage, V_{S} - $V_{IS(AZ)}$, is applied across the sense resistor R_{IS} . An additional high ohmic series resistor may be needed in the application to prevent high V_{IS} being applied directly to the application monitoring circuit.

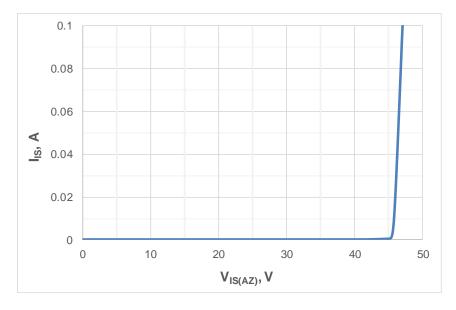


Figure 11. Typical IIs Overvoltage Clamp Characteristic



Protection Features (continued)

Also during V_S overvoltage transient the voltage V_S -OUT is clamped and the excess voltage, V_S -V_{DS(AZ)}, is applied across the load R_L. V_S-OUT is the same clamp described under the earlier section <u>Output Inductive Load Clamp</u>.

Reverse Battery Protection

During reverse battery the output body diode is conducting current limited by the load itself resulting in power dissipation and the current in the ground and logic inputs has to be limited by external resistor components. No operating functions are available in this condition.

Overload Protection

During overload the output current is limited to a value depending on the V_{DS} voltage resulting in high dissipation in the output power stage. Sustained operation in this mode will raise the internal junction temperature until dynamic or absolute overtemperature protection cycling begins. There is a dynamic ($\Delta T_{J(SW)}$) and an absolute ($T_{J(SC)}$) temperature sensor. Figure 12 gives a sketch of overload protection.

If the temperature rise of the power stage versus the cooler control area exceeds $\Delta T_{J(SW)}$ then the device will be turned off until the rise falls to a reset level. Each cycle causes the absolute temperature to increase a little.

If the absolute temperature reaches $T_{J(SC)}$ then the device will be turned off until the absolute temperature falls by $\Delta T_{J(SC)}$. The device will continue to cycle to $T_{J(SC)}$ as long as the fault condition remains.

The IS pin outputs I_{IS(FAULT)} during load current limitation, during dynamic overtemperature cycling, and absolute overtemperature cycling.

Both channels are independently overload protected and if both are in overtemperature shutdown there is no restart synchronization. As only one channel can be monitored on the IS pin it is not recommended to use both channels connected in parallel.

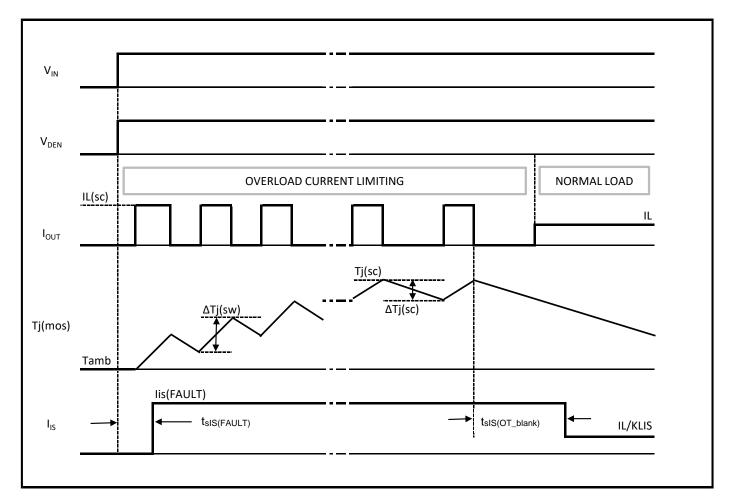


Figure 12. Overload Protection Diagram



Protection Electrical Characteristics

(Unless otherwise specified: $8V < V_S < 18V$, $-40^{\circ}C < T_J < +150^{\circ}C$; typical values based on $V_S = 13.5V$, $T_J = +25^{\circ}C$)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Loss of Ground Protection						
Iout(gnd)	Output leakage current (Note 14)	Vs = 28V GND disconnected	_	0.1	_	mA
Reverse Ba	ttery Protection					
VDS(REV)	Reverse output voltage (Note 15)	I _L = -1A, T _J = +150°C	0.2	0.65	0.7	V
Overvoltag	e Protection	•				
Vs(AZ)	Vs to GND clamping	Is = 5mA	41	47	53	V
Overload P	rotection	·				
I _{L5(SC)}	Load current limit	V _{DS} = 5V	8	11	15	Α
I _{L28(SC)}	Load current limit (Note 14)	V _{DS} = 28V	_	5	_	Α
I _{L(RMS)}	Load current during overtemperature cycling (Note 14)	R _{SHORT} = 0.1Ω L _{SHORT} = 5μH	_	2	_	А
ΔT _J (sw)	Dynamic temperature rise during cycling (Note 16)	_	_	80	_	K
T _{J(SC)}	Thermal shutdown temperature (Note 17)	_	+150	+170	+200	°C
$\Delta T_{J(SC)}$	Thermal hysteresis (Note 17)	_		20	_	K

- 14. Not subject to production test, guaranteed by design.
- 15. During reverse battery the body diode will conduct with a voltage drop V_{DS(REV)}.
- 16. Functional test only.
 17. Functional test only at T_J = +150°C.

Diagnostic Functionality - Detailed Description

In normal operation the IS pin outputs a small analog sense current proportional to the main OUT current flowing in the power MOSFET depending upon which channel is selected by the DSEL pin. In the case where it is disabled by the DEN pin it becomes high impedance.

V _{DEN}	VDSEL	IS Output
L	Х	Z
Н	L	Channel 0 diagnostics
Н	Н	Channel 1 diagnostics

Table 2. Diagnostic Truth Table

During overload/current limit operation/overtemperature/high temperature gradient or open load in the OFF-state, the IS pin outputs a defined current $I_{\text{IS}(\text{FAULT})}$ greater than normal sense currents for normal loads.

During ON-state operation with open load, normal OFF-state, or OFF-state with inductive load ring-off current still flowing, the IS current is approximately zero.



Diagnostic Functionality – Detailed Description (continued)

Operating Condition	V _{INx}	V _{DEN}	Voutx	IS Output Current, I _{IS} (Note 18)
Normal operation	L H	H H	Z H	Z = I _L / K _I LIS
Current limiting	Н	Н	Н	lis(fault)
Short circuit OUT to GND	L H	H H	L L	Z IIS(FAULT)
Overtemperature	L H	H H	Z Z	Z IIS(FAULT)
Short circuit OUT to Vs	L H	H H	H H	IIS(FAULT) < IL / Kilis (Note 19)
Open load	L L H	H H H	< VOL(OFF) > VOL(OFF) H	Z IIS(FAULT) (Note 20) < IIS(OL)
Inverse load current	L H	H H	H H	lis(fault)
All	Х	L	Х	Z

Table 3. Operational Truth Table (Note 21)

18. The appropriate channel is selected by the DSEL pin. Notes:

- 19. A low resistance short between OUT and V_S will reduce the output current, I_L and therefore reduce the analog sense current, I_{IS}.
- 20. With external pullup resistor.
 21. H = high level; L = low level; Z = high impedance, voltage depends on external circuit; X = don't care.



Diagnostic Diagrams

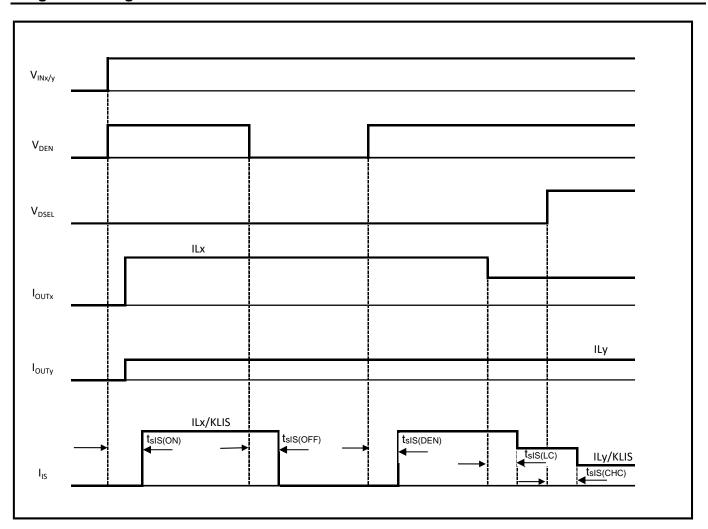


Figure 13. IS Signal Timing Diagram



Diagnostic Diagrams (continued)

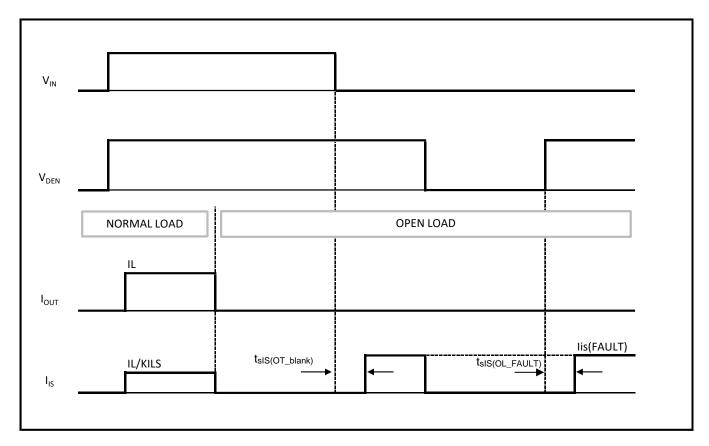


Figure 14. Open-Load Timing Diagram



Diagnostic Electrical Characteristics (Unless otherwise specified: $8V < V_S < 18V$, $-40^{\circ}C < T_J < +150^{\circ}C$; typical values based on $V_S = 13.5V$, $T_J = +25^{\circ}C$)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Open-Load	d Detection					<u> </u>
V _{DS(OL)}	Open load OFF state detection voltage	V _{IN} = 0V, V _{DEN} = 4.5V	4	4.9	6	V
I _{L(OL)}	Open load ON state detection current	V _{IN} = V _{DEN} = 4.5V I _{IS(OL)} = 22µA	5	_	30	mA
Current Se	nse Pin					
lis(DIS)	Current sense leakage current	V _{IN} = 4.5V, V _{DEN} = 0V I _L = 2A	_	_	1	μΑ
VIS(SAT)	VS to IS saturation voltage	VIN = 0V, VDEN = 4.5V IIS = 6mA, VOUT = VS > 10V	_	_	3	V
I _{IS(FAULT)}	Current sense under fault conditions	VIN = VIS = 0V, VDEN = 4.5V VOUT = VS > 10V	6	15	35	mA
$V_{IS(AZ)}$	VS to IS clamp voltage	I _{IS} = 5mA	41	47	53	V
Load Curre	ent Sense					
Kılıso	Sense current ratio I _L = 50mA		-30%	610	+30%	_
Kılısı	Sense current ratio I _L = 0.25A	Vin = Vden = 4.5V	-18%	560	+18%	_
Kılıs2	Sense current ratio I _L = 0.5A		-8%	560	+8%	_
Kılıs3	Sense current ratio I _L = 1A		-5%	560	+5%	_
Kılıs4	Sense current ratio I _L = 2A		-5%	550	+5%	_
ΔKILIS	Sense current ratio variation I _L = 1A versus I _L = 0.5A		-4%	0	+4%	_
Diagnostic	Timings					
t _{SIS(ON)}	Current sense settling time to 90% lis after IN and DEN high	$V_S = 13.5V$ $I_L = 1A, R_{IS} = 1.2k\Omega$	_	_	250	μs
tsIS(DEN)	Current sense settling time to 90% lis after DEN high	$V_S = 13.5V, V_{IN} = 4.5V$ $I_L = 1A, R_{IS} = 1.2k\Omega$	_	_	20	μs
tsIS(LC)	Current sense settling time to 90% lis after load current change	$V_S = 13.5V$, $V_{IN} = V_{DEN} = 4.5V$ $I_L = 0.5A$ to 1A, $R_{IS} = 1.2k\Omega$	_	_	20	μs
t _S IS(OL_ FAULT)	Diagnostic fault current settling time to 90% I _{IS(FAULT)} after DEN high with OFF state openload condition	$V_{IN} = 0V$, $V_{OUT} = V_S = 13.5V$ $R_{IS} = 1.2k\Omega$	_	_	150	μs
t _{SIS(FAULT)}	Diagnostic fault current settling time to 90% I _{IS(FAULT)} after IN and DEN high with overload condition	$V_{DS} = 5V$, $R_{IS} = 1.2k\Omega$	_	_	250	μs
tsIS(OT_ blank)	Diagnostic fault current off delay time to 90% IIS(FAULT) after overtemperature condition returning to normal operation (Note 22)	$V_{IN} = V_{DEN} = 4.5V$ $R_{IS} = 1.2k\Omega$	_	150	_	μs
tsIS(OFF)	Current sense fall time to < 50% lis after DEN low	$V_{IN} = 4.5V$, $I_L = 1A$ $R_{IS} = 1.2k\Omega$		_	30	μs
t _{sIS(CHC)}	Current sense settling time to 90% I _{IS} after DSEL high	$\begin{aligned} &V_S = 13.5V, \ V_{IN0} = V_{IN1} = 4.5V \\ &V_{DEN} = 4.5V \\ &I_{L0} = 1A, \ I_{L1} = 0.5A \\ &R_{IS} = 1.2k\Omega \end{aligned}$		_	20	μs

Note:

22. Not subject to production test, guaranteed by design.



Input Pins

The input circuit is compatible with 3.3V and 5V logic levels. The input diode provides ESD protection. If the pin is left open the internal tie down resistor will keep the output off. A Schmitt trigger provides switching hysteresis to avoid an undefined state if there is a slowly rising or falling voltage on the IN pin. Figure 15 shows the electrical equivalent circuit.

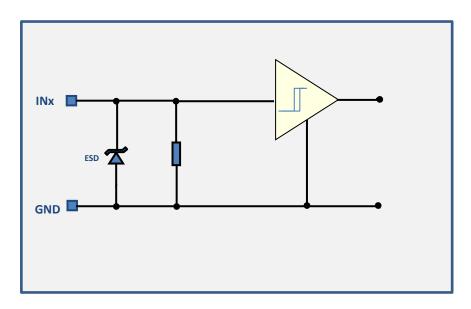


Figure 15. Input Pin Circuitry

The DEN and DSEL pins have the same circuitry as the IN pin.

Input Electrical Characteristics

(Unless otherwise specified: $8V < V_S < 18V$, $-40^{\circ}C < T_J < +150^{\circ}C$; typical values based on $V_S = 13.5V$, $T_J = +25^{\circ}C$)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
INx Pin	Nx Pin							
V _{IN(L)}	Low level input voltage	_	-0.3	_	0.8	V		
V _{IN(H)}	High level input voltage	_	2	_	6	V		
VIN(HYS)	Input voltage hysteresis	_	_	0.25	_	V		
I _{IN(L)}	Low level input current	V _{IN} = 0.8V	1	3	25	μΑ		
lin(H)	High level input current	V _{IN} = 5.5V	2	8	25	μΑ		
DEN Pin								
V _{DEN(L)}	Low level input voltage	_	-0.3	_	0.8	V		
VDEN(H)	High level input voltage	_	2	_	6	V		
V _{DEN(HYS)}	Input voltage hysteresis	_	_	0.25	_	V		
IDEN(L)	Low level input current	V _{DEN} = 0.8V	1	3	25	μΑ		
IDEN(H)	High level input current	V _{DEN} = 5.5V	2	8	25	μA		
DSEL Pin								
V _{DSEL(L)}	Low level input voltage	_	-0.3	_	0.8	V		
VDSEL(H)	High level input voltage	_	2	_	6	V		
VDSEL(HYS)	Input voltage hysteresis	_	_	0.25	_	V		
I _{DSEL(L)}	Low level input current	V _{DSEL} = 0.8V	1	3	25	μΑ		
IDSEL(H)	High level input current	V _{DSEL} = 5.5V	2	8	25	μΑ		



Characterisation – General Product

Minimum Functional Supply Voltage

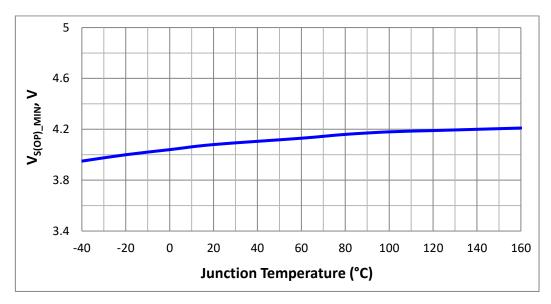


Figure 16. Minimum Functional Supply Voltage $V_{S(OP_MIN)} = f(T_J)$

Undervoltage Shutdown

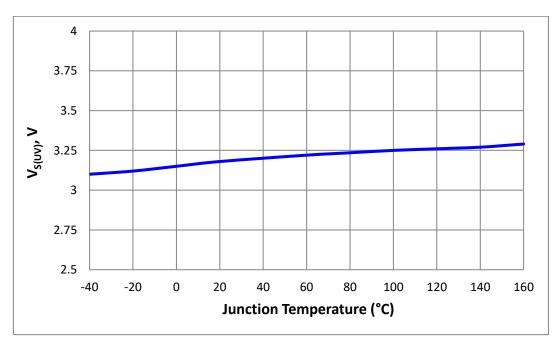


Figure 17. Undervoltage Shutdown $V_{S(UV)} = f(T_J)$



Characterisation – General Product (continued)

Current Consumption One Channel Active

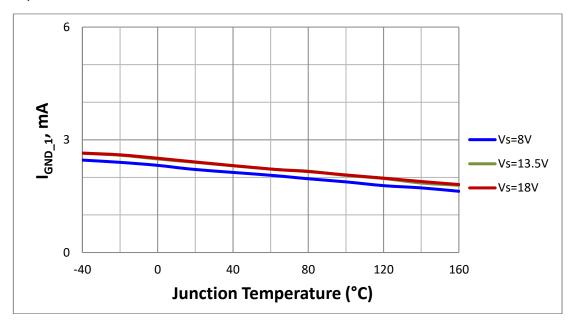


Figure 18. Current Consumption for Whole Device with Load, Channel Active I_{GND} = f(T_J;V_S)

Current Consumption Two Channels Active

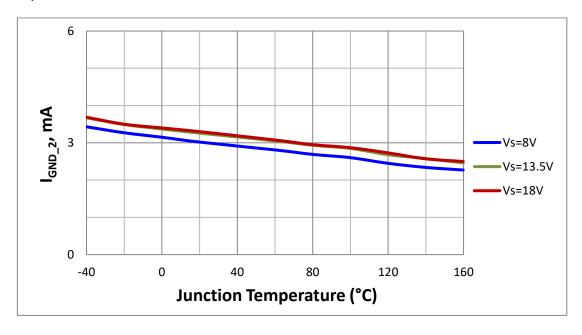


Figure 19. Current Consumption for Whole Device with Load, Channel Active IGND = f(TJ;VS)



Characterisation – General Product (continued)

Standby Current for Whole Device with Load

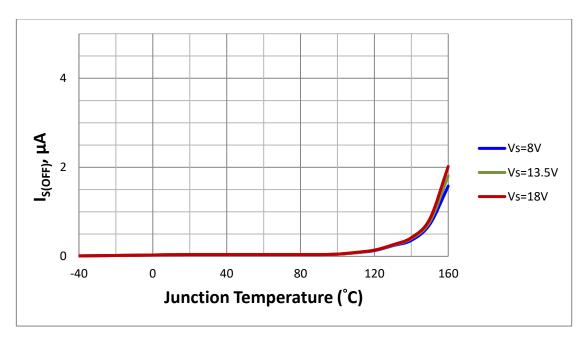


Figure 20. Standby Current for Whole Device with Load, $Is(OFF) = f(T_J; V_S)$



Characterisation - Power Stage

Output Voltage Drop Limitation at Low Load Current

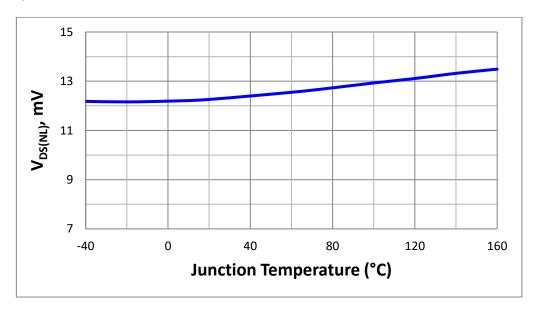


Figure 21. Output Voltage Drop Limitation at Low Load Current V_{DS(NL)} = f(T_J;V_S)

Output Voltage Drop Limitation at Low Load Current

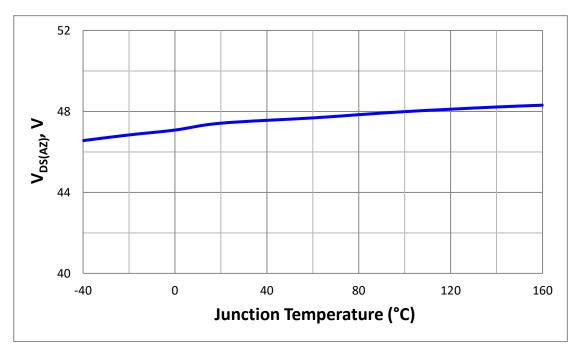


Figure 22. Drain to Source Clamp Voltage $V_{DS(AZ)} = f(T_J)$



Characterisation - Power Stage (continued)

Slew Rate at Turn ON

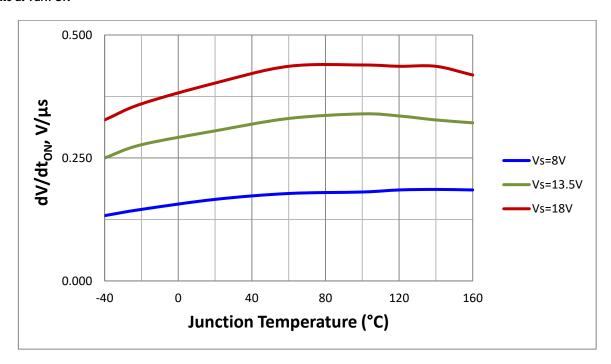


Figure 23. Slew Rate at Turn ON dV/dtoN = f(TJ;Vs)

Slew Rate at Turn OFF

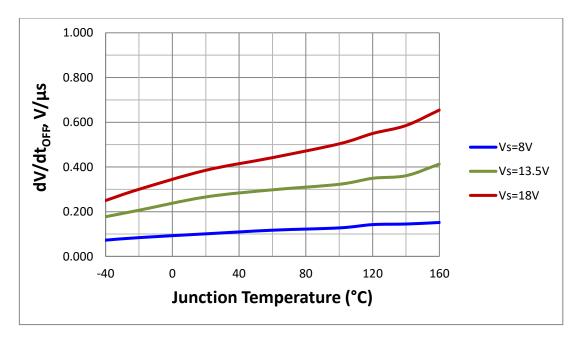


Figure 24. Slew Rate at Turn OFF dV/dtoff = f(TJ;Vs)



Characterisation - Power Stage (continued)

Turn ON Time

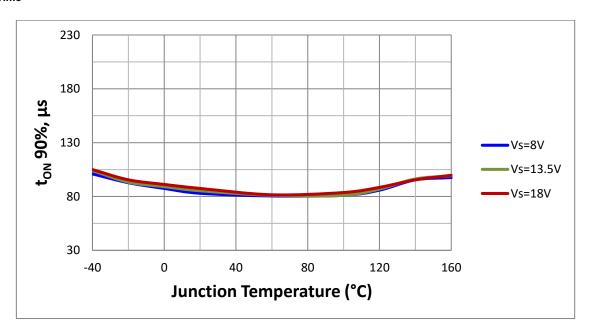


Figure 25. Turn ON toN = $f(T_J;V_S)$, $R_L = 12\Omega$

Turn OFF Time

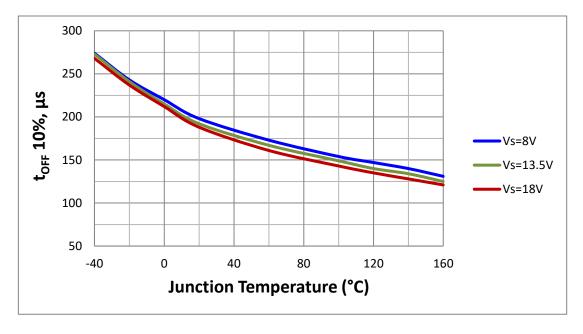


Figure 26. Turn OFF toff = $f(T_J; V_S)$, $R_L = 12\Omega$



Characterisation – Power Stage (continued)

Switch ON Energy

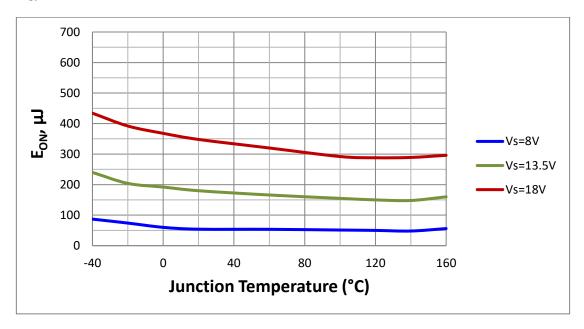


Figure 27. Switch ON Energy $E_{ON} = f(T_J; V_S)$, $R_L = 12\Omega$

Switch OFF Energy

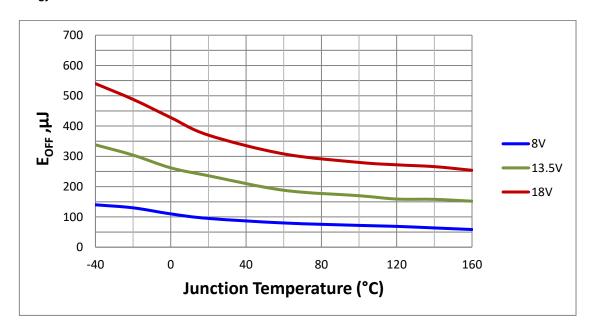


Figure 28. Switch OFF Energy $E_{OFF} = f(T_J; V_S)$, $R_L = 12\Omega$



Characterisation - Protection

Overload Condition with Low Output Voltage Drop

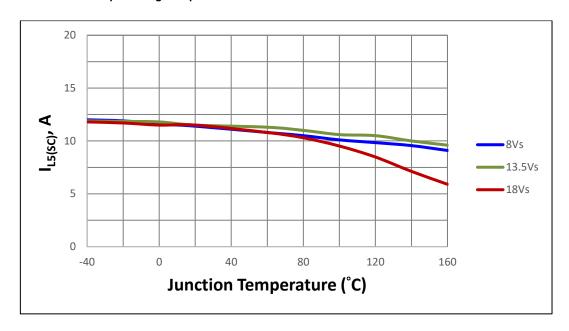


Figure 29. Overload Condition with Low Output Voltage Drop IL5(SC) = f(TJ;VS)

Overload Condition with High Output Voltage Drop

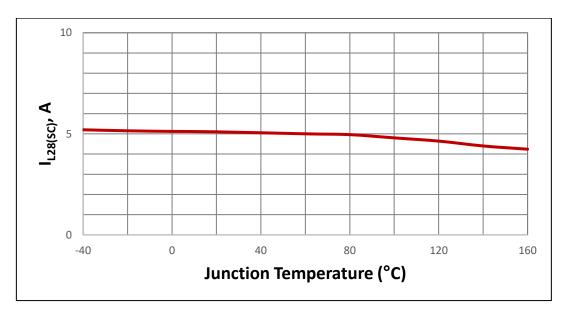


Figure 30. Overload Condition with High Output Voltage Drop $I_{L28(SC)} = f(T_J; V_S)$



Characterisation – Diagnostic Mechanism

Current Sense at No Load

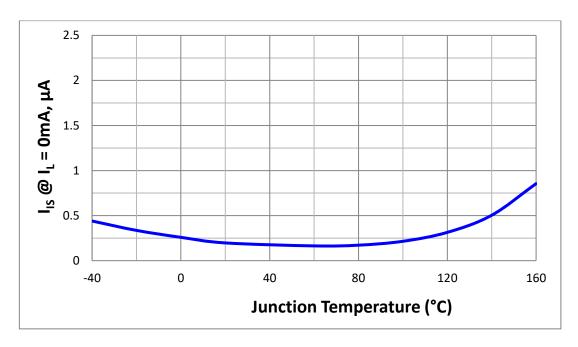


Figure 31. Current Sense at No Load $I_{IS} = f(T_J; V_S)$

Open-Load Detection Threshold in ON State

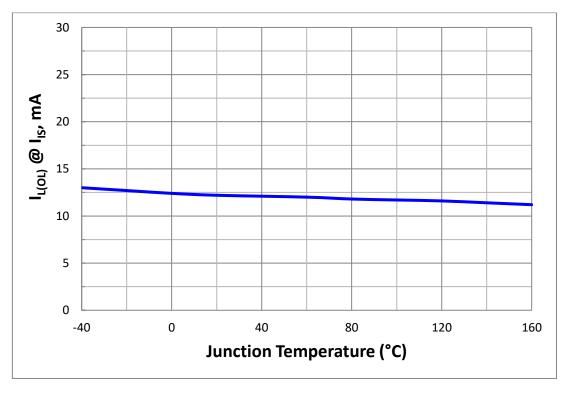


Figure 32. Open-Load Detection ON State Threshold $I_{L(OL)} = f(T_J; V_S)$



Characterisation - Diagnostic Mechanism (continued)

Sense Signal Maximum Voltage

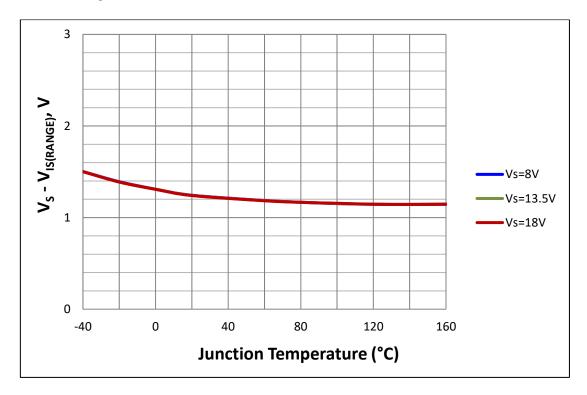


Figure 33. Sense Signal Maximum Voltage Vs - VIS(RANGE) = f(TJ;Vs)

Sense Signal Maximum Current

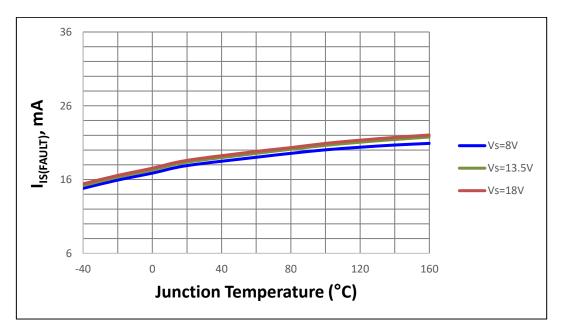


Figure 34. Sense Signal Maximum Current in Fault Condition $I_{IS(FAULT)} = f(T_J; V_S)$



Characterisation – Input Pins

Input Voltage Threshold ON to OFF

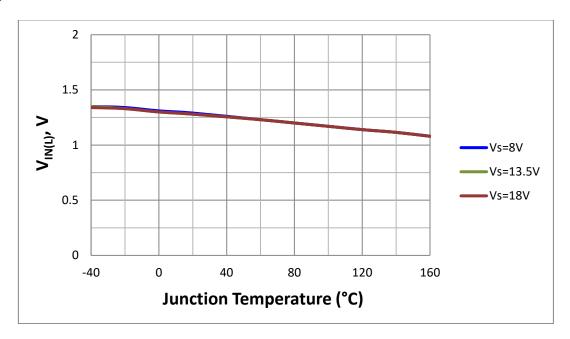


Figure 35. Input Voltage Threshold $V_{IN(L)} = f(T_J; V_S)$

Input Voltage Threshold OFF to ON

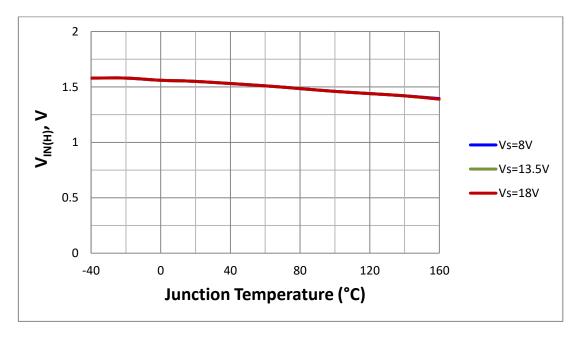


Figure 36. Input Voltage Threshold $V_{IN(H)} = f(T_J; V_S)$



Characterisation - Input Pins (continued)

Input Voltage Hysteresis

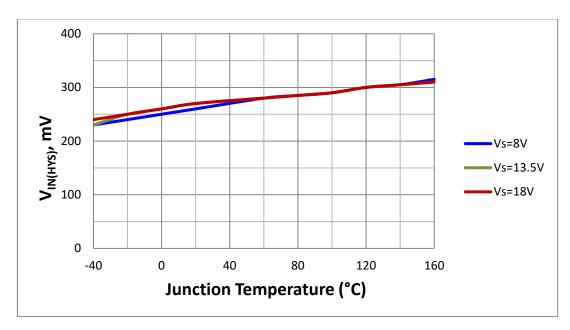


Figure 37. Input Voltage Hysteresis $V_{IN(HYS)} = f(T_J; V_S)$

Input Current High Level

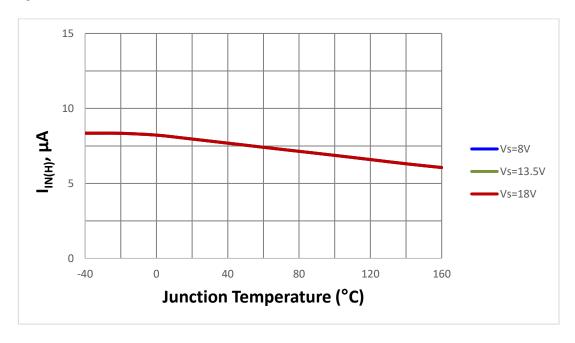


Figure 38. Input Current High Level $I_{IN(H)} = f(T_J; V_S)$



Application Information (Note 23)

Note: The following information is given as a hint for the implementation of the device only and shall not be regarded as a description or warranty of a certain functionality, condition or quality of the device.

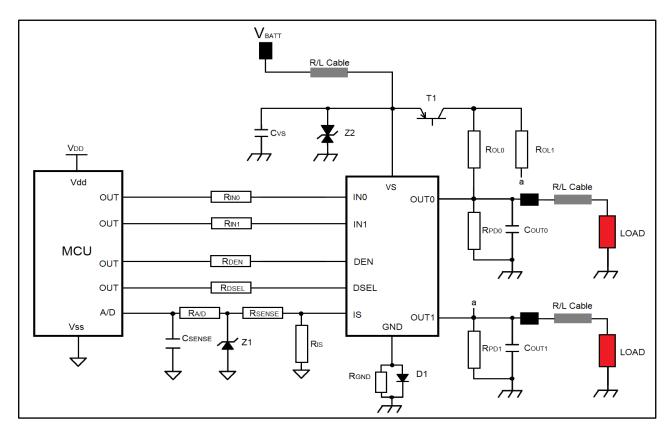


Figure 39. Application Circuit Diagram

Note: 23. This is a simplified example of an application circuit. The function must be verified in the real application.

Reference	Value	Purpose
Rinx	4.7kΩ	Connect to the micro controller for overvoltage, reverse polarity protections
R _{DEN}	4.7kΩ	Connect to the micro controller for overvoltage, reverse polarity protections
R _{PDx}	47kΩ	Improve immunity to electromagnetic noise
Rıs	1.2kΩ	Sense resistor
Rsense	4.7kΩ	Overvoltage, reverse polarity, loss of ground. Value to be tuned with micro controller specification
R _{OLx}	1.5kΩ	For open load in OFF diagnostic
R _{A/D}	4.7kΩ	Protection for the micro controller during overvoltage, reverse polarity
RGND	1kΩ	To keep the device GND at a stable potential during clamping
D1	BAS21	Protection of the device during reverse polarity
Z1	7V Zener diode	Protection of the micro controller during overvoltage
Z2	36V Zener diode	Protection of the device during overvoltage
T1	BC 807	Switch the battery voltage for open load in OFF diagnostic
C _{SENSE}	100pF	Sense signal filtering
Cvs	100nF	Filtering of the voltage spikes on the battery line
Соитх	4.7nF	Protection of the device during ESD and BCI

Table 4. Bill of Materials



Ordering Information (Note 24)

Part Number	Package	Marking	Reel Size (inches)	Tape Width (mm)	Packing	
Fait Number					Qty.	Carrier
ZXMS82180S14PQ-13	SO-14EP	ZXMS82180	13	16	2500	Reel

Note: 24. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information

);; ZXMS82180 YYWW

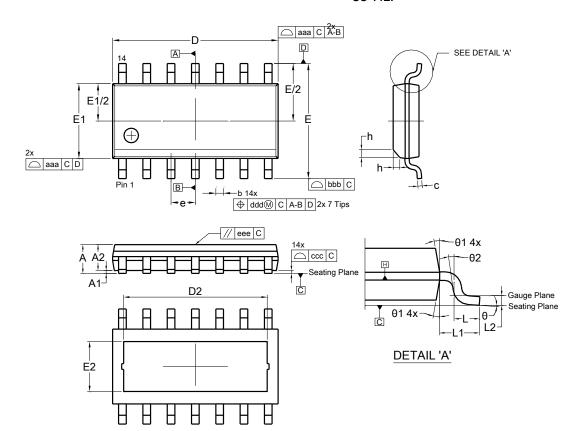
JH: Manufacturer's Code Marking
ZXMS82180: Product Type Marking Code
YY or YY: Year (ex: 23 = 2023)
WW or WW: Week 01 to 52;
52 represents week 52 and 53



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

SO-14EP

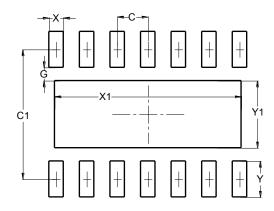


SO-14EP					
Dim	Min	Max	Тур		
Α		1.75			
A1	0.00	0.10			
A2	1.25	1.55			
b	0.31	0.51			
С	0.10	0.25			
D	8.55	8.75	-		
D2	7.40	7.60	7.50		
Е	5.80	6.20			
E1	3.80	4.00			
E2	2.50	2.70	2.60		
е	1.27 BSC				
h	0.25	0.50	1		
L	0.40	1.27	-		
L1	1.04 REF				
L2	0.25 BSC				
θ	0°	8°			
θ1	5°	15°	-		
θ2	0°				
aaa	0.10				
bbb	0.20				
CCC		0.10			
ddd		0.25			
eee	0.10				
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

SO-14EP



Dimensions	Value	
Dillielisions	(in mm)	
С	1.270	
C1	5.400	
G	0.550	
X	0.600	
X1	7.750	
Y	1.500	
Y1	2.800	

Mechanical Data

- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Plated Leads, Solderable per MIL-STD-202, Method 208 @3
- Weight: 0.15 grams (Approximate)



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NCV8412ASTT3G FPF2260ATMX SLG5NT1757V NCP45780IMN24RTWG AP2151AMP-13 NCP45540IMNTWG-L XC8111AA01MR-G TPS2022P FPF2495BUCX NCP45650IMNTWG DK5V100R20S BTS7020-2EPA BTT6100-2ERA BTS71220-4ESA DK5V100R15M
WS3220C9-9/TR AW32405CSR BTT6030-2ERA TLE75602-ESH BTS5200-4EKA DK5V150R25M DK5V45R25 DK5V100R25S
AW35206FOR BTS7120-2EPA TLE75008-ESD BTS7040-1EPA BTT6030-1ERA DK5V60R10S DK5V45R25S DK5V60R10
DK5V100R15S DK5V85R15 WS4632C-4/TR WS3241C-12/TR WS4622C-4/TR